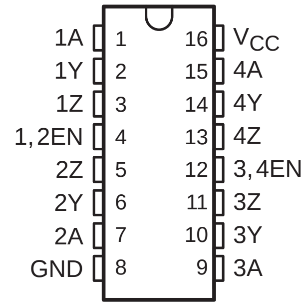
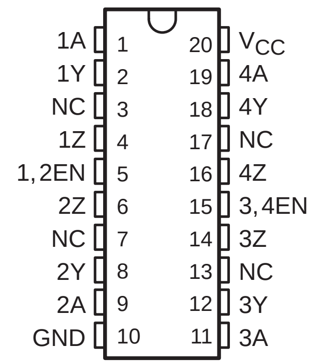
- **Meets or Exceeds the Requirements of ANSI Standards EIA/TIA-422-B and RS-485 and ITU Recommendation V.11.**
- **Designed for Multipoint Transmission on Long Bus Lines in Noisy Environments**
- **3-State Outputs**
- **Common-Mode Output Voltage Range of –7 V to 12 V**
- **Active-High Enable**
- **Thermal Shutdown Protection**
- **Positive- and Negative-Current Limiting**
- **Operates From Single 5-V Supply**
- **Low Power Requirements**
- **Functionally Interchangeable With MC3487**

N PACKAGE
(TOP VIEW)



DW PACKAGE
(TOP VIEW)



NC – No internal connection

description

The SN75174 is a monolithic quadruple differential line driver with 3-state outputs. It is designed to meet the requirements of ANSI Standards EIA/TIA-422-B and RS-485 and ITU Recommendation V.11. The device is optimized for balanced multipoint bus transmission at rates up to 4 megabaud. Each driver features wide positive and negative common-mode output voltage ranges making it suitable for party-line applications in noisy environments.

The SN75174 provides positive- and negative-current limiting and thermal shutdown for protection from line fault conditions on the transmission bus line. Shutdown occurs at a junction temperature of approximately 150°C. This device offers optimum performance when used with the SN75173 or SN75175 quadruple differential line receivers.

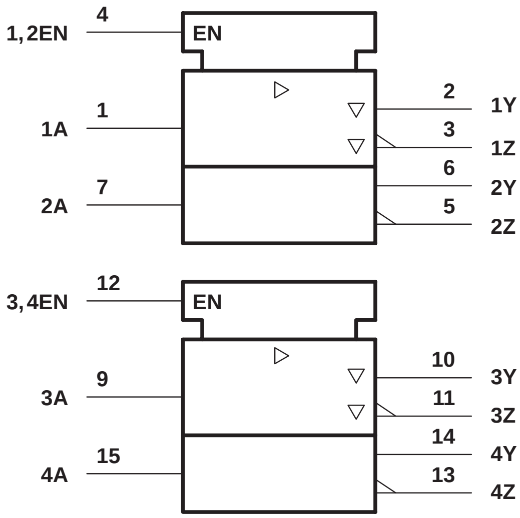
The SN75174 is characterized for operation from 0°C to 70°C.

FUNCTION TABLE
(each driver)

INPUT	ENABLE	OUTPUTS	
		Y	Z
H	H	H	L
L	H	L	H
X	L	Z	Z

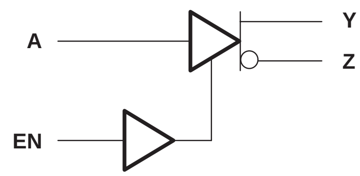
H = TTL high level, X = irrelevant,
L = TTL low level, Z = high impedance (off)

logic symbol†



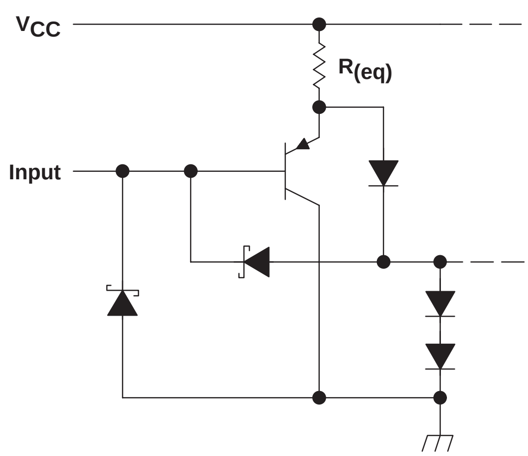
† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram, each driver (positive logic)



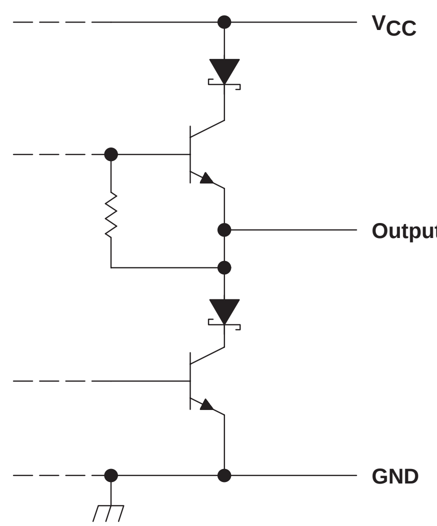
schematics of inputs and outputs

EQUIVALENT OF EACH INPUT



Data Inputs: $R_{(eq)}$ = 3 kΩ NOM
Enable Inputs: $R_{(eq)}$ = 8 kΩ NOM
$R_{(eq)}$ = equivalent resistor

TYPICAL OF ALL OUTPUTS



absolute maximum ratings over operating free-air temperature (unless otherwise noted)†

Supply voltage, V_{CC} (see Note 1) . . . . 7 V
Output voltage range, V_O . . . . –10 V to 15 V
Input voltage, V_I . . . . 5.5 V
Continuous total dissipation . . . . See Dissipation Rating Table
Operating free-air temperature range, T_A . . . . 0°C to 70°C
Storage temperature range, T_{stg} . . . . –65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds . . . . 260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to the network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	$T_A \le 25°C$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25°C$	$T_A = 70°C$ POWER RATING
DW	1125 mW	9.0 mW/°C	720 mW
N	1150 mW	9.2 mW/°C	736 mW

recommended operating conditions

	MIN	NOM	MAX	UNIT
Supply voltage, V_{CC}	4.75	5	5.25	V
High-level input voltage, V_{IH}	2			V
Low-level input voltage, V_{IL}			0.8	V
Common-mode output voltage, V_{OC}			–7 to 12	V
High-level output current, I_{OH}			–60	mA
Low-level output current, I_{OL}			60	mA
Operating free-air temperature, T_A	0		70	°C

electrical characteristics over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V_{IK}	Input clamp voltage	I_I = –18 mA				–1.5	V
V_{OH}	High-level output voltage	V_{IH} = 2 V, I_{OH} = –33 mA	V_{IL} = 0.8 V,		3.7		V
V_{OL}	Low-level output voltage	V_{IH} = 2 V, I_{OL} = 33 mA	V_{IL} = 0.8 V,		1.1		V
V_O	Output voltage	I_O = 0		0		6	V
$\|V_{OD1}\|$	Differential output voltage	I_O = 0		1.5	6	6	V
$\|V_{OD2}\|$	Differential output voltage	R_L = 100 Ω,	See Figure 1	1/2 V_{OD1} or 2‡			V
		R_L = 54 Ω,	See Figure 1	1.5	2.5	5	V
V_{OD3}	Differential output voltage	See Note 2		1.5		5	V
$\Delta\|V_{OD}\|$	Change in magnitude of differential output voltage§	R_L = 54 Ω or 100 Ω,	See Figure 1			±0.2	V
V_{OC}	Common-mode output voltage¶					+3 –1	V
$\Delta\|V_{OC}\|$	Change in magnitude of common-mode output voltage§					±0.2	V
I_O	Output current with power off	V_{CC} = 0,	V_O = – 7 V to 12 V			±100	µA
I_{OZ}	High-impedance-state output current	V_O = – 7 V to 12 V				±100	µA
I_{IH}	High-level input current	V_I = 2.7 V				20	µA
I_{IL}	Low-level input current	V_I = 0.5 V				–360	µA
I_{OS}	Short-circuit output current	V_O = – 7 V				–180	mA
		V_O = V_{CC}				180	
		V_O = 12 V				500	
I_{CC}	Supply current (all drivers)	No load	Outputs enabled		38	60	mA
			Outputs disabled		18	40	

† All typical values are at V_{CC} = 5 V and T_A = 25°C.
‡ The minimum V_{OD2} with a 100-Ω load is either 1/2 V_{OD1} or 2 V, whichever is greater.
§ $\Delta|V_{OD}|$ and $\Delta|V_{OC}|$ are the changes in magnitude of V_{OD} and V_{OC}, respectively, that occur when the input is changed from a high level to a low level.
¶ In ANSI Standard EIA/TIA-422-B, V_{OC}, which is the average of the two output voltages with respect to ground, is called output offset voltage, V_{OS}.
NOTE 2: See EIA Standard RS-485.

switching characteristics, V_{CC} = 5 V, T_A = 25°C

PARAMETER		TEST CONDITIONS		MIN	TYP	MAX	UNIT
$t_{d(OD)}$	Differential-output delay time	R_L = 54 Ω,	See Figure 2		45	65	ns
$t_{t(OD)}$	Differential-output transition time				80	120	ns
t_{PZH}	Output enable time to high level	R_L = 110 Ω,	See Figure 3		80	120	ns
t_{PZL}	Output enable time to low level	R_L = 110 Ω,	See Figure 4		55	80	ns
t_{PHZ}	Output disable time from high level	R_L = 110 Ω,	See Figure 3		75	115	ns
t_{PLZ}	Output disable time from low level	R_L = 110 Ω,	See Figure 3		18	30	ns

SYMBOL EQUIVALENTS

DATA SHEET PARAMETER	EIA/TIA-422-B	RS-485
V_O	V_{oa}, V_{ob}	V_{oa}, V_{ob}
$\lvert V_{OD1}\rvert$	V_o	V_o
$\lvert V_{OD2}\rvert$	V_t (R_L = 100 Ω)	V_t (R_L = 54 Ω)
$\lvert V_{OD3}\rvert$		V_t (Test Termination) Measurement 2)
$\Delta\lvert V_{OD}\rvert$	$\lvert\,\lvert V_t\rvert - \lvert\overline{V}_t\rvert\,\rvert$	$\lvert\,\lvert V_t\rvert - \lvert\overline{V}_t\rvert\,\rvert$
V_{OC}	$\lvert V_{os}\rvert$	$\lvert V_{os}\rvert$
$\Delta\lvert V_{OC}\rvert$	$\lvert V_{os} - \overline{V}_{os}\rvert$	$\lvert V_{os} - \overline{V}_{os}\rvert$
I_{OS}	$\lvert I_{sa}\rvert$,$\lvert I_{sb}\rvert$	
I_O	$\lvert I_{xa}\rvert$,$\lvert I_{xb}\rvert$	I_{ia},I_{ib}

PARAMETER MEASUREMENT INFORMATION

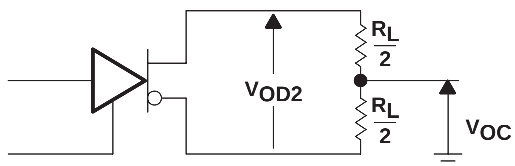
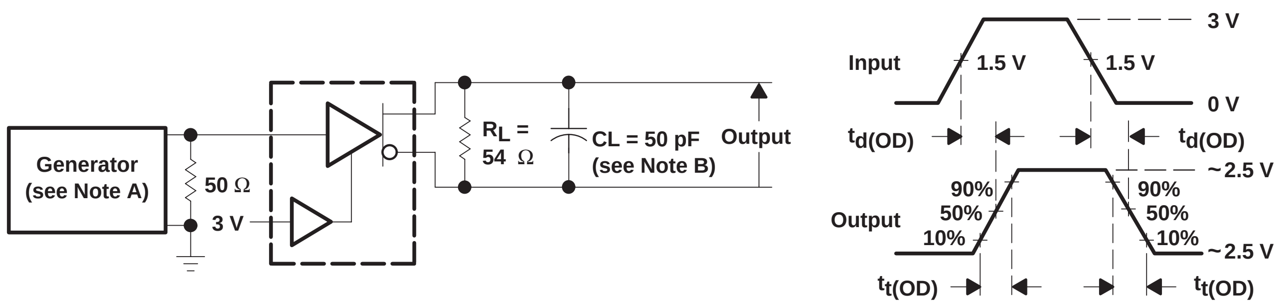


Figure 1. Differential and Common-Mode Output Voltages



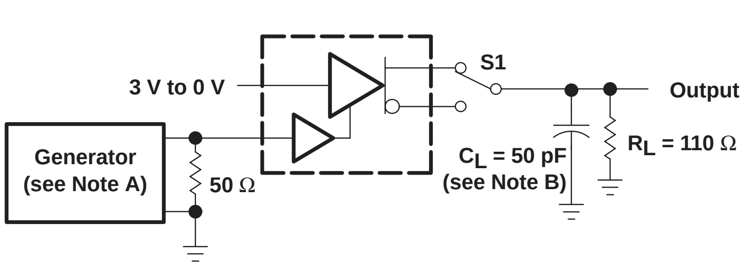
TEST CIRCUIT **VOLTAGE WAVEFORMS**

NOTES: A. The input pulse is supplied by a generator having the following characteristics: $t_r \leq 5$ ns, $t_f \leq 5$ ns, PRR ≤ 1 MHz, duty cycle = 50%, Z_O = 50 Ω.

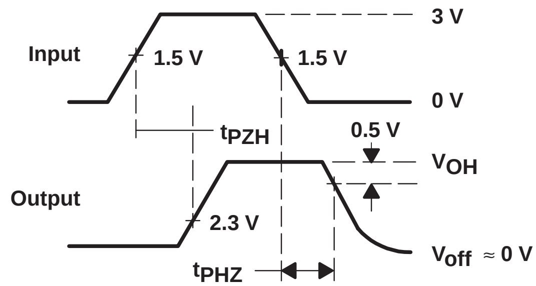
B. C_L includes probe and stray capacitance.

Figure 2. Differential-Output Test Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION



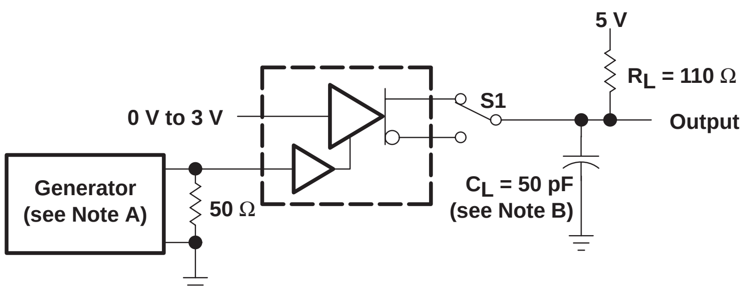
TEST CIRCUIT



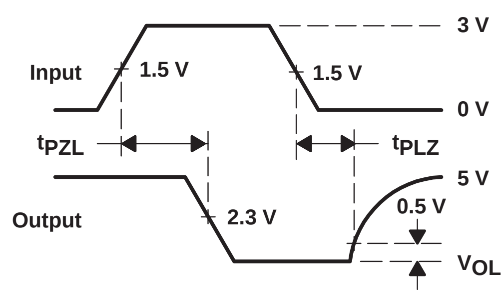
VOLTAGE WAVEFORMS

NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR ≤ 1 MHz, duty cycle = 50%, t_r ≤ 5 ns, t_f ≤ 5 ns, Z_O = 50 Ω.
B. C_L includes probe and stray capacitance.

Figure 3. Test Circuit and Voltage Waveforms



TEST CIRCUIT



VOLTAGE WAVEFORMS

NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR ≤ 1 MHz, duty cycle = 50%, t_r ≤ 5 ns, t_f ≤ 5 ns, Z_O = 50 Ω.
B. C_L includes probe and stray capacitance.

Figure 4. Test Circuit and Voltage Waveforms

TYPICAL CHARACTERISTICS

HIGH-LEVEL OUTPUT VOLTAGE
vs
HIGH-LEVEL OUTPUT CURRENT

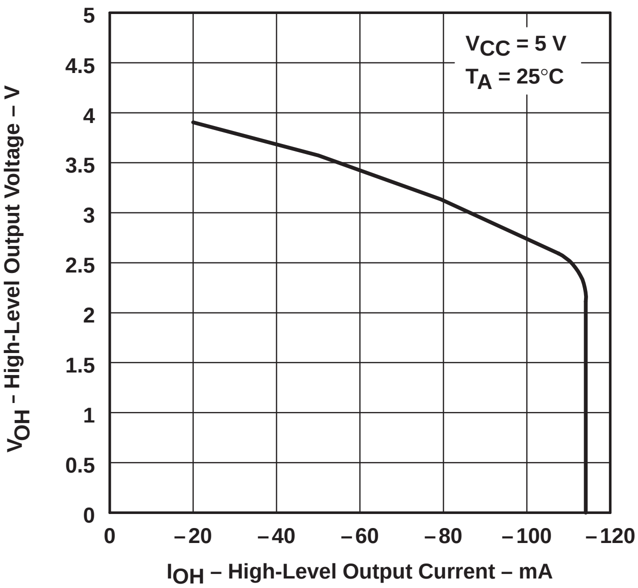


Figure 5

LOW-LEVEL OUTPUT VOLTAGE
vs
LOW-LEVEL OUTPUT CURRENT

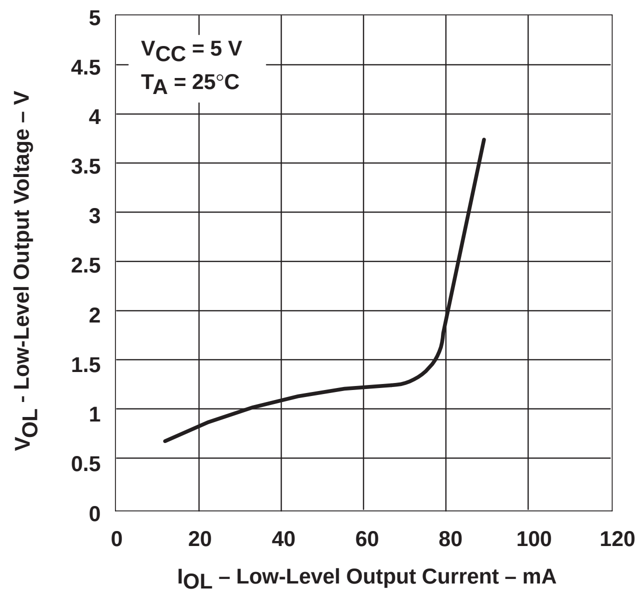


Figure 6

DIFFERENTIAL OUTPUT VOLTAGE
vs
OUTPUT CURRENT

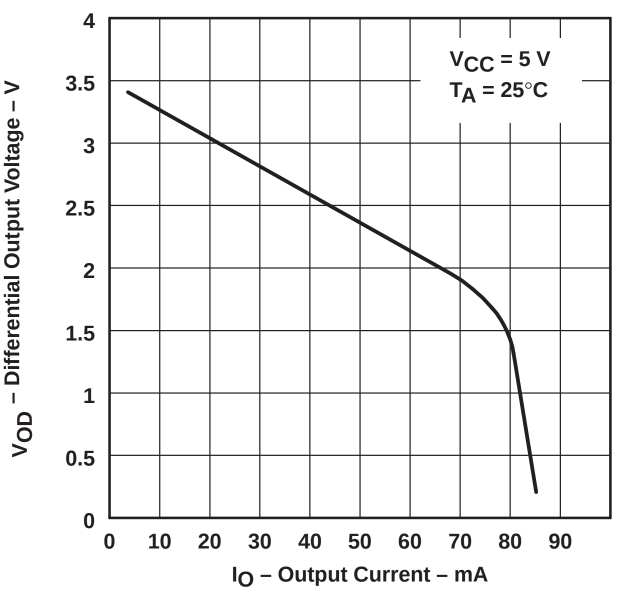


Figure 7

OUTPUT CURRENT
vs
OUTPUT VOLTAGE

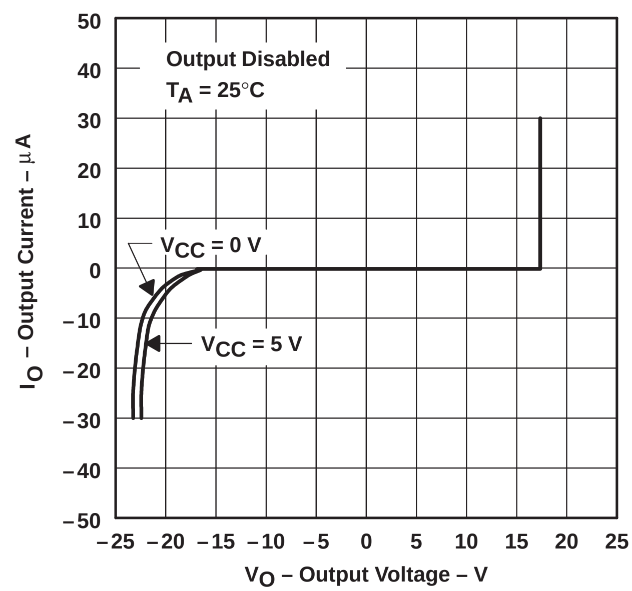


Figure 8

TYPICAL CHARACTERISTICS

SUPPLY CURRENT vs SUPPLY VOLTAGE

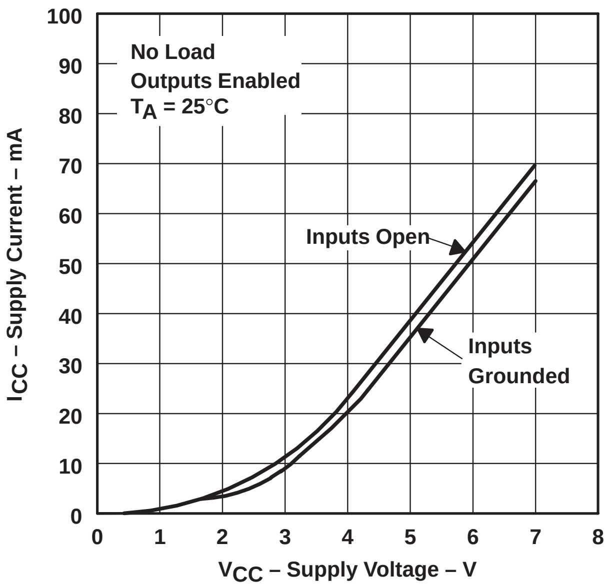


Figure 9

SUPPLY CURRENT vs SUPPLY VOLTAGE

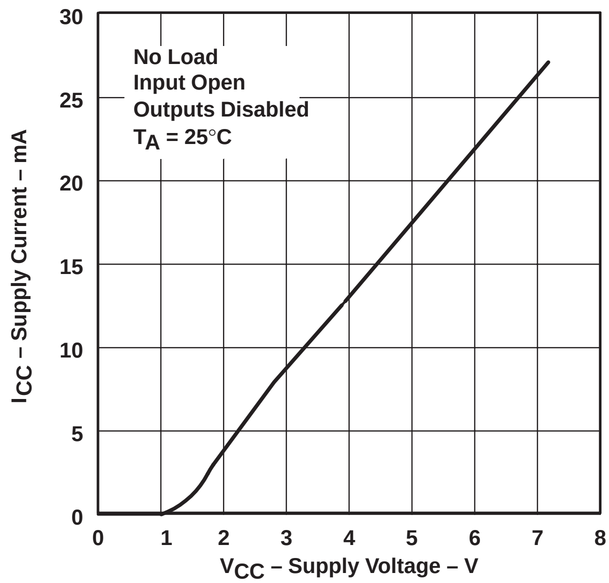
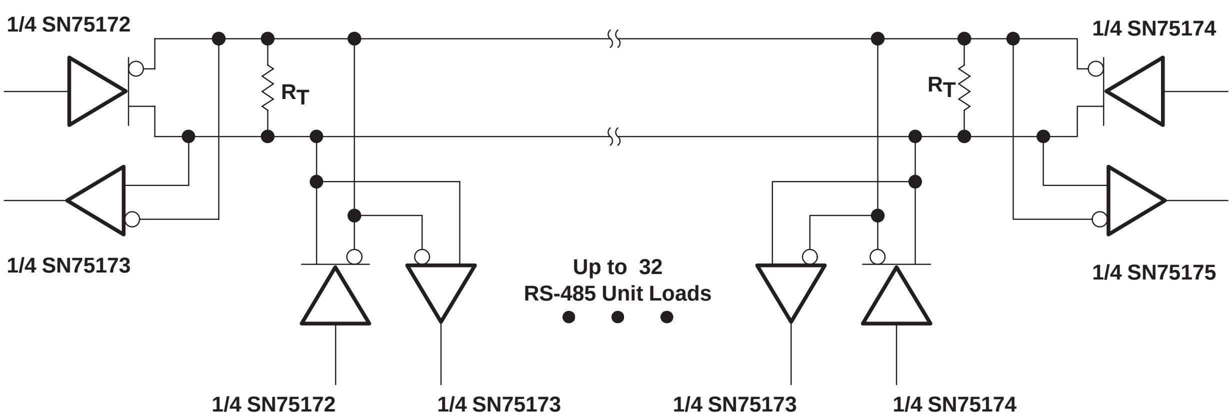


Figure 10

APPLICATION INFORMATION



NOTE: The line length should be terminated at both ends in its characteristic impedance ($R_T = Z_O$). Stub lengths off the main line should be kept as short as possible.

Figure 11. Typical Application Circuit

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